20 V, 1.0 A, Low V_{CE(sat)} **NPN Transistor**

ON Semiconductor's e²PowerEdge family of low V_{CE(sat)} transistors are miniature surface mount devices featuring ultra low saturation voltage (V_{CE(sat)}) and high current gain capability. These are designed for use in low voltage, high speed switching applications where affordable efficient energy control is important.

Typical applications are DC-DC converters and power management in portable and battery powered products such as cellular and cordless phones, PDAs, computers, printers, digital cameras and MP3 players. Other applications are low voltage motor controls in mass storage products such as disc drives and tape drives. In the automotive industry they can be used in air bag deployment and in the instrument cluster. The high current gain allows e²PowerEdge devices to be driven directly from PMU's control outputs, and the Linear Gain (Beta) makes them ideal components in analog amplifiers.

• This is a Pb-Free Device

MAXIMUM RATINGS ($T_A = 25^{\circ}C$)

Rating	Symbol	Max	Unit
Collector-Emitter Voltage	V _{CEO}	20	Vdc
Collector-Base Voltage	V _{CBO}	40	Vdc
Emitter-Base Voltage	V _{EBO}	6.0	Vdc
Collector Current – Continuous	Ι _C	1.0	Α
Collector Current – Peak	I _{CM}	2.0	Α
Electrostatic Discharge	ESD	HBM Class 3B MM Class C	

Characteristic	Symbol	Max	Unit	
Total Device Dissipation $T_A = 25^{\circ}C$	P _D (Note 1)	255	mW	
Derate above 25°C		2.0	mW/°C	
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$ (Note 1)	490	°C/W	
Total Device Dissipation $T_A = 25^{\circ}C$	P _D (Note 2)	300	mW	
Derate above 25°C		2.4	mW/∘C	
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$ (Note 2)	415	°C/W	
Junction and Storage Temperature Range	T _J , T _{stg}	–55 to +150	°C	

THERMAL CHARACTERISTICS

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

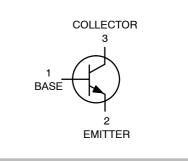
FR-4 @ 100 mm², 1 oz. copper traces.
FR-4 @ 500 mm², 1 oz. copper traces.

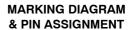


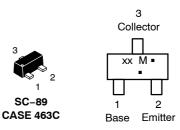
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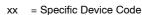
http://onsemi.com

20 VOLTS, 1.0 AMPS NPN LOW V_{CE(sat)} TRANSISTOR









М = Date Code*

= Pb-Free Package

(Note: Microdot may be in either location) *Date Code orientation may vary depending

upon manufacturing location.

ORDERING INFORMATION

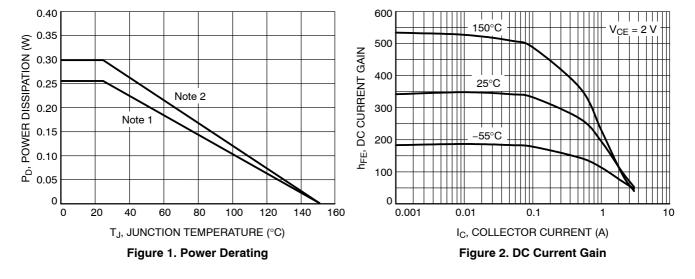
Device	Package	Shipping [†]
NSS20101JT1G	SC-89 (Pb-Free)	3000/Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS ($T_A = 25^{\circ}C$ unless otherwise noted)

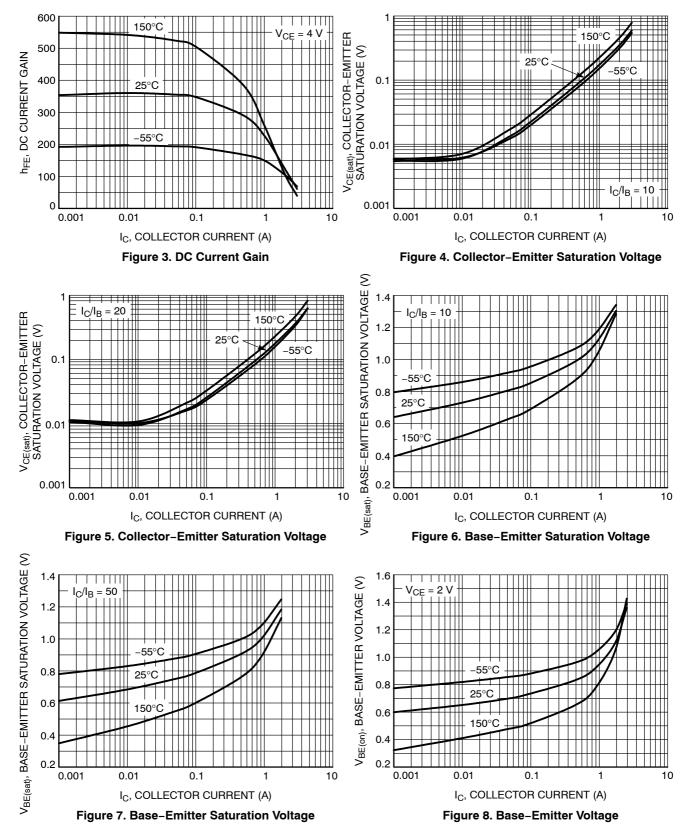
Characteristic	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS				•	
Collector – Emitter Breakdown Voltage $(I_C = 10 \text{ mAdc}, I_B = 0)$	V _{(BR)CEO}	20			Vdc
Collector – Base Breakdown Voltage $(I_{C} = 0.1 \text{ mAdc}, I_{E} = 0)$	V _{(BR)CBO}	40			Vdc
Emitter – Base Breakdown Voltage $(I_E = 0.1 \text{ mAdc}, I_C = 0)$	V _{(BR)EBO}	6.0			Vdc
Collector Cutoff Current (V _{CB} = 30 Vdc, I _E = 0)	I _{СВО}			0.1	μAdc
Emitter Cutoff Current (V _{EB} = 5.0 Vdc)	I _{EBO}			0.1	μAdc
ON CHARACTERISTICS					
DC Current Gain (Note 3) ($I_C = 10 \text{ mA}, V_{CE} = 2.0 \text{ V}$) ($I_C = 100 \text{ mA}, V_{CE} = 2.0 \text{ V}$) ($I_C = 500 \text{ mA}, V_{CE} = 2.0 \text{ V}$) ($I_C = 1.0 \text{ A}, V_{CE} = 2.0 \text{ V}$)	h _{FE}	200 200 150 100		500	
Collector – Emitter Saturation Voltage (Note 3) ($I_C = 10 \text{ mA}, I_B = 0.5 \text{ mA}$) ($I_C = 0.10 \text{ A}, I_B = 0.010 \text{ A}$) ($I_C = 0.5 \text{ A}, I_B = 0.050 \text{ A}$) ($I_C = 1.0 \text{ A}, I_B = 0.1 \text{ A}$)	V _{CE(sat)}			0.015 0.040 0.115 0.220	V
Base – Emitter Saturation Voltage (Note 3) $(I_{C} = 0.5 \text{ A}, I_{B} = 50 \text{ mA})$	V _{BE(sat)}			1.1	V
Base – Emitter Turn–on Voltage (Note 3) ($I_C = 0.5 \text{ A}, V_{CE} = 2.0 \text{ V}$)	V _{BE(on)}			0.90	V
Cutoff Frequency (I _C = 100 mA, V _{CE} = 2.0 V, f = 100 MHz)	f _T		350		MHz
Input Capacitance (V _{EB} = 0.5 V, f = 1.0 MHz)	Cibo		40	1	pF
Output Capacitance (V _{CB} = 4.0 V, f = 1.0 MHz)	Cobo		6		pF

3. Pulsed Condition: Pulse Width = 300 msec, Duty Cycle \leq 2%.

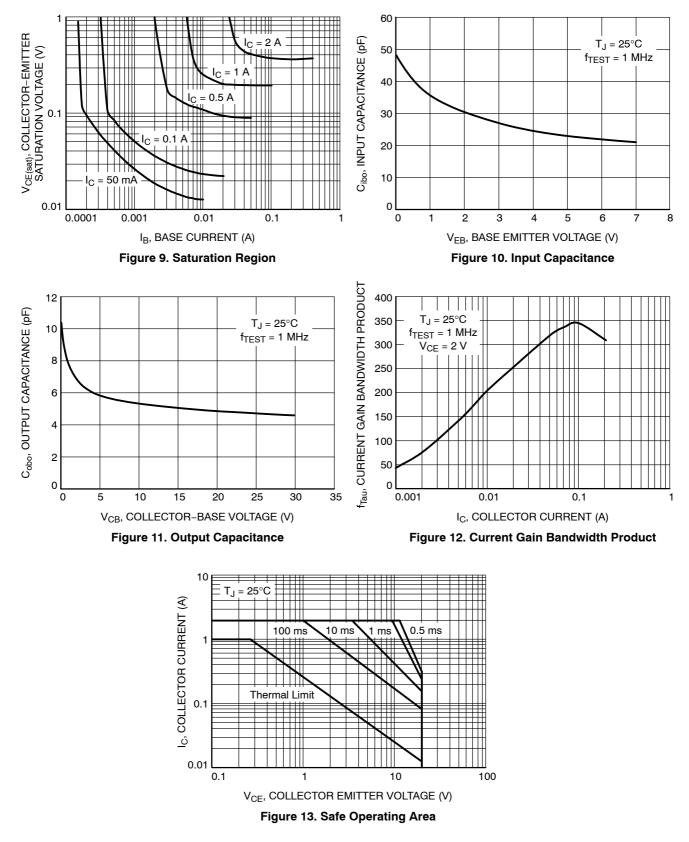


TYPICAL CHARACTERISTICS



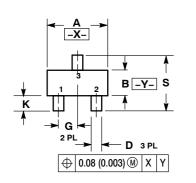


TYPICAL CHARACTERISTICS



PACKAGE DIMENSIONS

SC-89. 3 LEAD CASE 463C-03 **ISSUE C**

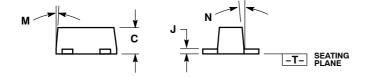


NOTES:

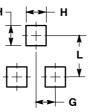
- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- 2. CONTROLLING DIMENSION: MILLIMETERS 3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE

MATERIAL. 4. 463C-01 OBSOLETE, NEW STANDARD 463C-02.

	MILLIMETERS INCHES					
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	1.50	1.60	1.70	0.059	0.063	0.067
В	0.75	0.85	0.95	0.030	0.034	0.040
С	0.60	0.70	0.80	0.024	0.028	0.031
D	0.23	0.28	0.33	0.009	0.011	0.013
G	0.50 BSC			0.020 BSC		
н	0.53 REF			0.021 REF		
J	0.10	0.15	0.20	0.004	0.006	0.008
ĸ	0.30	0.40	0.50	0.012	0.016	0.020
L	1.10 REF			0.043 REF		
М			10			10
Ν			10 -			10 -
S	1.50	1.60	1.70	0.059	0.063	0.067



SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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